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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)				Applicant Masakazu FURUKAWA et al.	AUG 16 2002	
				Filing Date January 5, 2000	Group 3742	TECHNOLOGY CENTER R3700

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER			DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
S	4 -	3 2 4	2	7 6	11/13/92	JAPAN			
	7 -	2 6 3	5	3 0	10/13/95	JAPAN			
	7 -	3 0 7	3	7 7	11/21/95	JAPAN			
.	8 -	3 0 6	6	2 9	11/22/96	JAPAN			
.	9 -	1 7 2	0	5 5	06/30/97	JAPAN			
.	9 -	2 1 3	4	5 5	08/15/97	JAPAN			
.	9 -	3 0 6	6	4 2	11/28/97	JAPAN			
.	1 0	1 8 9	6	9 6	07/21/98	JAPAN			
.	1 1	- 1 2	0	5 3	01/19/99	JAPAN			
.	1 1	- 7 4	0	6 4	03/16/99	JAPAN			
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

R	1	English Language Abstract of JP 4-324276.
	2	English Language Abstract of JP 7-263530.
	3	English Language Abstract of JP 7-307377.
	4	English Language Abstract of JP 8-306629.
	5	English Language Abstract of JP 9-172055.
	6	English Language Abstract of JP 9-213455.
	7	English Language Abstract of JP 9-306642.
	8	English Language Abstract of JP 10-189696.
	9	English Language Abstract of JP 11-012053.
	1 0	English Language Abstract of JP 11-074064.
	1 1	English Language Abstract of JP 11-074336.

EXAMINER	S R	DATE CONSIDERED	7/15/04
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<i>SC</i>		4	-	8 7	1 7 9	03/19/92	JAPAN		
<i>SC</i>		8	-	2 1 8	1 7 2	08/27/96	JAPAN		
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)									
<i>SC</i>	1	English Language Abstract of JP 4-87179.							
<i>SC</i>	2	English Language Abstract of JP 8-218172.							
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